

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:
Uziel Landau

Patent No.: 6,261,433

Confirmation No.: 7462

Issued: July 17, 2001

For: ELECTRO-CHEMICAL
DEPOSITION SYSTEM AND
METHOD OF ELECTROPLATING
ON SUBSTRATES

MAIL STOP REISSUE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Group Art Unit: N/A

Examiner: N/A

I hereby certify that this correspondence and the documents referred to as attached therein are being deposited on 07/17/03, 2003 with the United States Postal Service in an envelope as "Express Mail Post Office to Addressee," mailing label No. EV331233581US addressed to: MAIL STOP REISSUE, Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.

07/17/03 
Date Signature

INFORMATION DISCLOSURE STATEMENT

The Applicants, and the Attorney who signs below on the basis of the information supplied by the inventor and the information in his file, submit herewith patents, publications, or other information of which they are aware, which may be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR § 1.56.

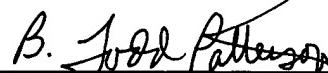
While the information submitted in this Information Disclosure Statement may be material pursuant to 37 CFR § 1.56, it is not intended to constitute an admission that any patent, publication, or other information referred to therein is prior art for this invention unless specifically designated as such.

In accordance with 37 CFR § 1.97, this Information Disclosure Statement is not to be construed as a representation that a search has been made or that no other possibly material information as defined under 37 CFR § 1.56(a) exists.

The patents and/or publications submitted herewith are set forth on the attached Form PTO-1449.

The Commissioner is hereby authorized to charge any fees required to make this submission acceptable to the Office, including any fees required by § 1.97 and/or 37 CFR § 1.17(p), to Deposit Account No. 20-0782/AMAT/2601 R 02/CMP/ECP/RKK.

Respectfully submitted,



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U.S. Department of Commerce, Patent and Trademark Office (PTO Form 1449 modified)		Docket No. AMAT/2601 R 02/CMP/ECP/RKK	Patent No. 6,261,433
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant Uziel Landau	Confirmation No.: 7462
(Use several sheets if necessary)		Issue Date July 17, 2001	Group N/A
U.S. Patent Documents			

*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
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Foreign Patent Documents

*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							YES	NO
	B1						<input type="checkbox"/>	<input type="checkbox"/>
	B2						<input type="checkbox"/>	<input type="checkbox"/>

OTHER ART

*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
	C1	
	C2	

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

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*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate	
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							YES	NO
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	B2						<input type="checkbox"/>	<input type="checkbox"/>
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